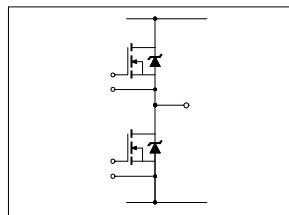


Features

- Low On-Resistance
- High Performance Optimised Built-in Fast Recovery Diodes
- Fully Characterized Capacitance and Avalanche Voltage and Current
- Optional SMT Thermystor Inside
- Aluminum Nitride DBC
- Very Low Stray Inductance Design for High Speed Operation



$$V_{DSS} = 500V$$

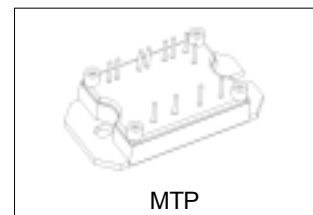
$$R_{DS(on) \text{ typ.}} = 0.087\Omega$$

$$I_D = 46A$$

$$@ T_C = 25^\circ C$$

Benefits

- Low Gate Charge Qg results in Simple Drive Requirement
- Improved Gate, Avalanche and Dynamic dv/dt Ruggedness
- Low Trr and Soft Diode Reverse Recovery
- Optimized for Welding, UPS and SMPS Applications
- Outstanding ZVS and High Frequency Operation
- Direct Mounting to Heatsink
- PCB Solderable Terminals
- Very Low Junction-to-Case Thermal Resistance



Absolute Maximum Ratings

Parameters			Max	Units
I _D	Continuous Drain Current @ V _{GS} = 10V	@ T _C = 25°C	46	A
		@ T _C = 100°C	29	
I _{DM}	Pulsed Drain Current (1)		180	
P _D	Maximum Power Dissipation	@ T _C = 25°C	800	W
		@ T _C = 100°C	320	
V _{GS}	Gate-to-Source Voltage		± 30	V
V _{ISOL}	RMS Isolation Voltage, Any Terminal to Case, t = 1 min		2500	
dv/dt	Peak Diode Recovery dv/dt (3)		25	V/ ns

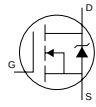
Electrical Characteristics @ $T_J = 25^\circ\text{C}$ (unless otherwise specified)

Parameters	Min	Typ	Max	Units	Test Conditions
$V_{(BR)DSS}$ Drain-to-Source Breakdown Voltage	500			V	$V_{GS} = 0V, I_C = 250\mu A$
$\Delta V_{(BR)DSS} / \Delta T_J$ Temperature Coeff. of Breakdown Voltage		0.6		V/ $^\circ\text{C}$	$I_D = 1mA$, reference to $T_J = 25^\circ\text{C}$
$R_{DS(ON)}$ Static Drain-to-Source On-Resistance		0.087		Ω	$V_{GS} = 15V, I_D = 28A$ (4)
$V_{GS(th)}$ Gate Threshold Voltage	3		5	V	$V_{DS} = V_{GS}, I_D = 250\mu A$
I_{DSS} Drain-to-Source Leakage Current			50	μA	$V_{DS} = 500V, V_{GS} = 0V$
			2	mA	$V_{DS} = 400V, V_{GS} = 0V, T_J = 125^\circ\text{C}$
I_{GSS} Gate-to-Source Forward Leakage			100	nA	$V_{GS} = 30V$
Gate-to-Source Reverse Leakage			-100		$V_{GS} = -30V$

Dynamic Characteristics @ $T_J = 25^\circ\text{C}$ (unless otherwise specified)

Parameters	Min	Typ	Max	Units	Test Conditions
g_{fs} Forward Transconductance	21			S	$V_{DS} = 50V, I_D = 46A$
Q_g Total Gate Charge			380	nC	$I_D = 46A$
Q_{gs} Gate-to-Source Charge			80		$V_{DS} = 400V$
Q_{gd} Gate-to-Drain ("Miller") Charge			190		$V_{GS} = 10V$ (4)
C_{iss} Input Capacitance		8110		pF	$V_{GS} = 0V$
C_{oss} Output Capacitance		960			$V_{DS} = 25V$
C_{rss} Reverse Transfer Capacitance		130			$f = 1.0\text{ MHz}$
C_{oss} Output Capacitance		11200			$V_{GS} = 0V, V_{DS} = 1.0V, f = 1.0\text{ MHz}$
C_{oss} Output Capacitance		240			$V_{GS} = 0V, V_{DS} = 400V, f = 1.0\text{ MHz}$
$C_{oss\text{ eff.}}$ Effective Output Capacitance		420			$V_{GS} = 0V, V_{DS} = 0V \text{ to } 400V$ (5)

Diode Characteristics @ $T_J = 25^\circ\text{C}$ (unless otherwise specified)

Parameters	Min	Typ	Max	Units	Test Conditions
I_S Continuous Source Current (Body Diode)			46	A	MOSFET symbol showing the integral reverse p-n junction diode 
I_{SM} Pulsed Source Current (Body Diode) (1)			180		
V_{SD} Diode Forward Voltage			1.5	V	$T_J = 25^\circ\text{C}, I_S = 46A, V_{GS} = 0V$ (4)
t_{rr} Reverse Recovery Time		170		ns	$T_J = 25^\circ\text{C}, I_F = 46A$
Q_{rr} Reverse Recovery Charge		0.8		μC	$di/dt = 100A/\mu s$ (4)
I_{RRM} Reverse Recovery Current		8.4		A	

Notes:

(1) Repetitive rating; pulse width limited by max. junction temperature

(2) Starting $T_J = 25^\circ\text{C}$, $L = 0.86mH$, $R_G = 25\Omega$ $I_{AS} = 46A$ (3) $I_{SD} \leq 46A$, $di/dt \leq 367A/\mu s$, $V_{DD} \leq V_{(BR)DSS}$, $T_J \leq 150^\circ\text{C}$ (4) Pulse width $\leq 400\mu s$; duty cycle $\leq 2\%$ (5) $C_{oss\text{ eff.}}$ is a fixed capacitance that gives the same charging time as C_{oss} while V_{DS} is rising from 0 to 80% V_{DSS}

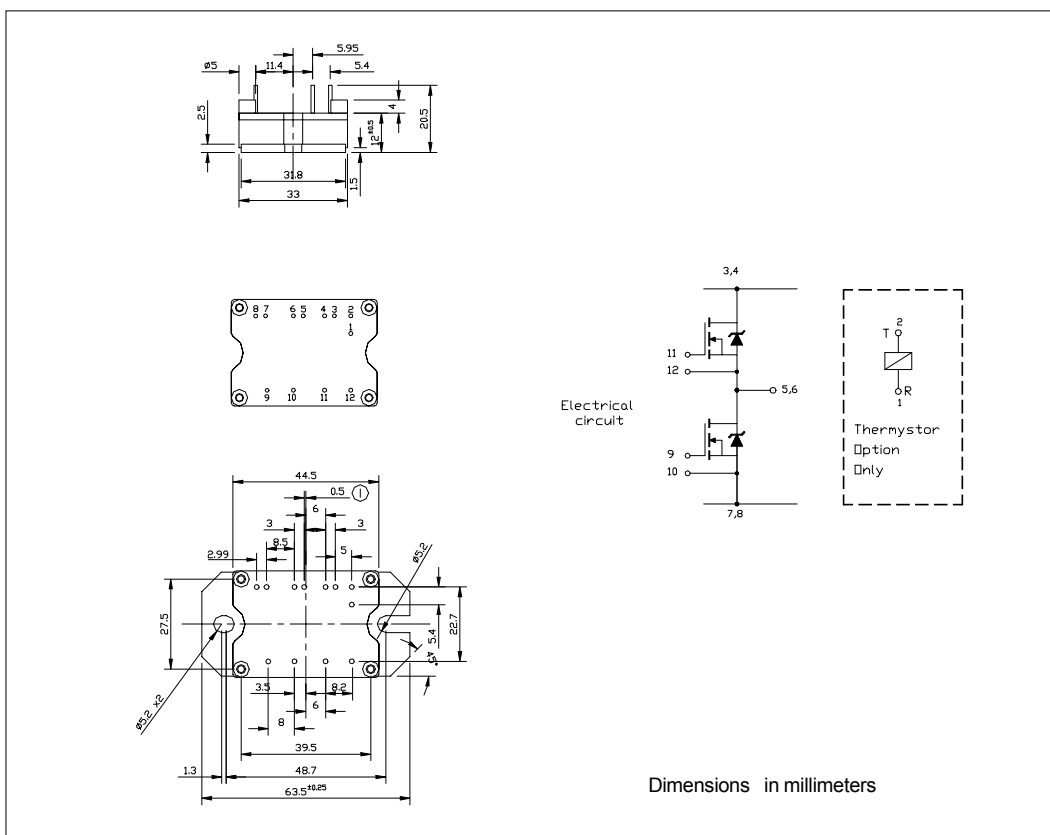
Thermal- Mechanical Specifications

Parameters		Min	Typ	Max	Units
T _J	Operating Junction Temperature Range	- 40		150	°C
T _{STG}	Storage Temperature Range	- 40		125	
R _{thJC}	Junction-to-Case			0.35	°C/ W
R _{thCS}	Case-to-Sink (Heatsink Compound Thermal Conductivity = 1 W/mK)		0.06		
	Weight		66		g

Avalanche Characteristics

Parameters		Min	Typ	Max	Units
E _{AS}	Single Pulse Avalanche Energy (2)			920	mJ
I _{AR}	Avalanche Current (1)			46	A
E _{AR}	Repetitive Avalanche Energy (1)			54	mJ

Outline Table



29MT050XH

Target Data 05/01

International
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Data and specifications subject to change without notice.
This product has been designed for Industrial Level.
Qualification Standards can be found on IR's Web site.

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